SN54ALS153 ... J PACKAGE

SDAS206A - APRIL 1982 - REVISED DECEMBER 1994

- Permit Multiplexing From n Lines to One Line
- Perform Parallel-to-Serial Conversion
- Strobe (Enable) Line Provided for Cascading (n Lines to n Lines)
- 'ALS253 and SN74AS253A Are 3-State Versions of These Parts
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

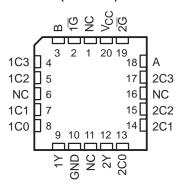
## description

These dual 1-of-4 data selectors/multiplexers contain inverters and drivers to supply full binary decoding data selection to the AND-OR gates. Separate strobe ( $\overline{G}$ ) inputs are provided for each of the two 4-line sections.

The SN54ALS153 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The SN74ALS153 and SN74AS153 are characterized for operation from 0°C to 70°C.

$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	SN74ALS153, SN74AS153 D OR N PACKAGE (TOP VIEW)								
	B [ 2 1C3 [ 3 1C2 [ 4 1C1 [ 5 1C0 [ 6 1Y [ 7	14] A 13] 2C3 12] 2C2 11] 2C1 10] 2C0							

SN54ALS153 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

		INP	UTS							
SEL	ECT		DA	TA						
В	Α	C0	C1	C2	C3	Ĩ				
Х	Х	Х	Х	Х	Х	Н	L			
L	L	L	Х	Х	Х	L	L			
L	L	н	Х	Х	Х	L	н			
L	Н	Х	L	Х	Х	L	L			
L	Н	Х	Н	Х	Х	L	н			
н	L	Х	Х	L	Х	L	L			
н	L	Х	Х	Н	Х	L	н			
н	Н	Х	Х	Х	L	L	L			
н	Н	Х	Х	Х	Н	L	н			

FUNCTION TABLE

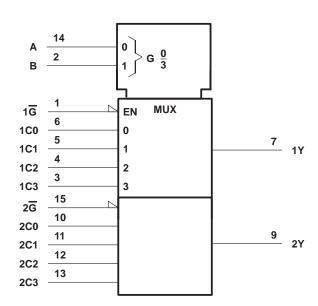
Select inputs A and B are common to both sections.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warrantly. Production processing does not necessarily include testing of all parameters.



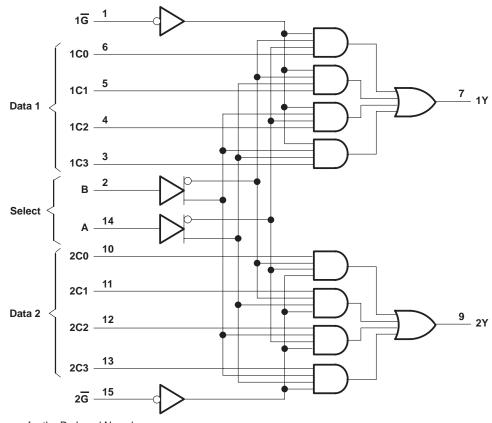
SDAS206A - APRIL 1982 - REVISED DECEMBER 1994

## logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.

## logic diagram (positive logic)



Pin numbers shown are for the D, J, and N packages.



SDAS206A - APRIL 1982 - REVISED DECEMBER 1994

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage, V <sub>CC</sub>	
Operating free-air temperature range, T <sub>A</sub> : SN54ALS153	–55°C to 125°C
SN74ALS153	
Storage temperature range	-65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN	54ALS1	53	SN74ALS153		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
ЮН	High-level output current			-1			-2.6	mA
IOL	Low-level output current			12			24	mA
TA	Operating free-air temperature	-55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	PARAMETER TEST CONDITIONS		SN	54ALS1	53	SN	53	UNIT	
PARAMETER	TEST CO	JNDITION3	MIN	TYP‡	MAX	MIN	typ‡	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	lj = -18 mA			-1.5			-1.5	V
	$V_{CC} = 4.5 V \text{ to } 5.5 V,$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2	2		V <sub>CC</sub> -2			
VOH	VCC = 4.5 V	I <sub>OH</sub> = -1 mA	2.4	3.3					V
	VCC = 4.5 V	I <sub>OH</sub> = -2.6 mA				2.4	3.2		
Max	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 12 mA		0.25	0.4		0.25	0.4	V
VOL		I <sub>OL</sub> = 24 mA					0.35	0.5	v
lj	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA
Ιн	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V			20			20	μΑ
١ <sub>IL</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V			-0.1			-0.1	mA
١ <sub>O</sub> §	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
ICC	V <sub>CC</sub> = 5.5 V,	All inputs at 4.5 V		7.5	14		7.5	14	mA

<sup>‡</sup> All typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25^{\circ}C$ .

§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



SDAS206A - APRIL 1982 - REVISED DECEMBER 1994

#### switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	CL RL	= 50 pF = 500 Ω	V to 5.5 ; 2, o MAX <sup>†</sup>	V,	UNIT
			SN54ALS153		SN74A	LS153	
			MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	A or B	Y	5	29	5	21	ns
<sup>t</sup> PHL			5	27	5	21	115
<sup>t</sup> PLH	Data	v	3	15	3	10	ns
<sup>t</sup> PHL	(any C)		2	18	4	15	115
<sup>t</sup> PLH	G	v	5	27	5	18	ns
<sup>t</sup> PHL	6		3	22	5	18	115

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>‡</sup>

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Operating free-air temperature range, T <sub>A</sub> : SN74AS153	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN74AS153		UNIT	
		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
ЮН	High-level output current			-15	mA
IOL	Low-level output current			48	mA
TA	Operating free-air temperature	0		70	°C



SDAS206A - APRIL 1982 - REVISED DECEMBER 1994

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN	SN74AS153			
	PARAMETER	TEST CONL	JIIONS	MIN		UNIT		
VIK		V <sub>CC</sub> = 4.5 V,	lı = – 18 mA			-1.2	V	
		$V_{CC} = 4.5 V \text{ to } 5.5 V,$	I <sub>OH</sub> = -2 mA	V <sub>CC</sub> -2			v	
VOH	Γ	V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = -15 mA	2.4			V	
VOL		V <sub>CC</sub> = 4.5 V,	I <sub>OL</sub> = 48 mA		0.35	0.5	V	
	А, В		N/ 7.)/			0.2		
łı	All others	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1	mA	
	А, В		N 07N		40	40		
Чн	All others	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V			20	μA	
	A, B		N 0 4 N			-1		
ΙL	All others	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V			-0.5	mA	
10‡		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30		-112	2 mA	
Іссн		V <sub>CC</sub> = 5.5 V			16	26	mA	
ICCL		V <sub>CC</sub> = 5.5 V			21	33	mA	

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.
<sup>‡</sup> The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I<sub>OS</sub>.

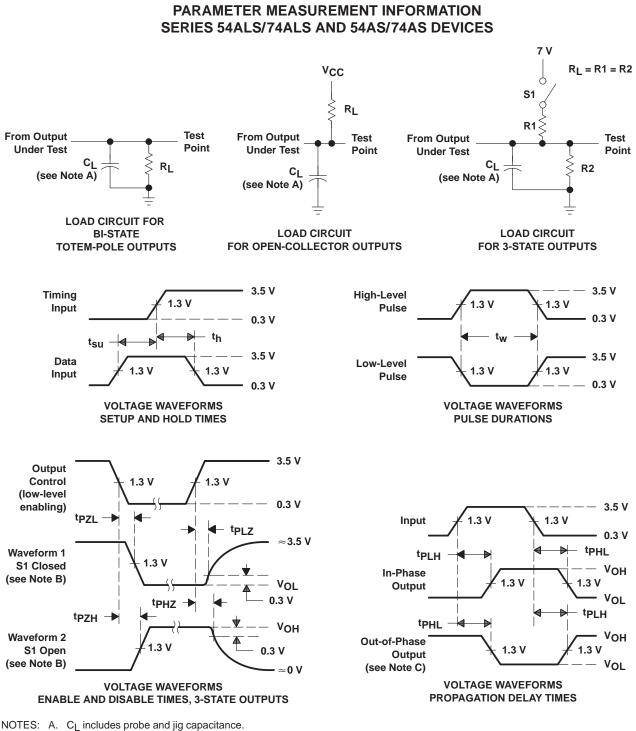
## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 V \text{ to } 5.5 V, \\ C_L = 50 \text{ pF}, \\ R_L = 500 \Omega, \\ T_A = \text{MIN to MAX} \\ \text{SN74AS153}$		UNIT
			MIN	MAX	
<sup>t</sup> PLH	A or B	Y	3	12.5	ns
<sup>t</sup> PHL			3	11	115
<sup>t</sup> PLH	Data	×	2	7	
<sup>t</sup> PHL	(any C)	Ť	2	8	ns
<sup>t</sup> PLH	G	v	3	11.5	
<sup>t</sup> PHL	G	l f	10	9	ns

§ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



SDAS206A - APRIL 1982 - REVISED DECEMBER 1994



 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. When measuring propagation delay items of 3-state outputs, switch S1 is open.

- C. When measuring propagation delay items of 3-state outputs, switch S1 is open. D. All input pulses have the following characteristics: PRR  $\leq$  1 MHz, t<sub>f</sub> = t<sub>f</sub> = 2 ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.
  - The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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